PCN Number:		20170926003				D	at	e: Se	ptember 28, 2017
Title: Datasheet for		r Datasheet for LMH0397							
Customer Contact:		PCN Manager					De t:	P Qu	ality Services
Cha	nge Type:								
	Assembly Site			Design				Wafe	- Bump Site
Assembly Process				Data Sheet			Wafer Bump Material		
	Assembly Materials			Part number change			Wafer Bump Process		
	Mechanical Specification		Test Site					Wafer Fab Site	
Packing/Shipping/Labeling		٦ 🗌	Test Process				Wafe	⁻ Fab Materials	
								Wafe	- Fab Process
Notification Details									
Description of Change:									
Texas Instruments Incorporated is announcing an information only notification etc. The product datasheet(s) is being updated as summarized below. The following change history provides further details.									
SNLSDBA - APRIL 2017 - REVISED SEPTEMBER 2017									
Changes from Original (April 2017) to Revision A Page									
Changed typical power consumption in CD Mode from 315 mW to 290 mW based on updated characterization data 1									
Changed NTps _{max} test condition max from 6 GHz to 50 MHz and < 20 mVp-p NOM to < 10 mVp-p									
	Changed typical and maximum current dissipation based on updated complete characterization data								
	Changed maximum current dissipation when acquiring lock based on updated complete characterization data								
	 Changed t_{R_F_SDI} minimum SD rise/fall time from 390 ps to 400 ps due to incorrect default settings								
	Changed typical t _R /t _F of OUT0 from 35 ps to 45 ps Added PRBS10 pattern to clarify AJ _{CD_MODE} and TMJ _{CD_MODE} Test Condition								
	Added PRBST0 pattern to clarify AJ _{CD_MODE} and TMJ _{CD_MODE} Test Condition								
	Changed TMJ _{CD_MODE} maximum spec from 8 01 to 0.45 01 typical because parameter is system dependent								
Added SMB03 SCL minimum nequency per SMB03 2.0 specifications Added Figure 1 to clarify definition of SMBus Timing Parameters in <i>Recommended SMBus Interface Timing</i> Specifications									
	 Added typical characteric curves for OUT0 VOD and de-emphasis vs. LMH0397 register settings								
					-				
 Changed clarification in Table 13 regarding reclocker behavior when used with non-SDI data rates									
Mode and CD Mode. 32 • Added mechanical, thermal pad, and land pattern drawings to the Package Option Addendum. 41									
	datasheet number	will be change	ging.	Change From:					Change Ter
Device Family				-					Change To:
LM	LMH10397			SNLS558					SNLS558A
The datasheet is considered "custom", for that reason; the document is not available on the TI website. Please contact the TI Customer Quality Engineer (CQE) for a copy of the datasheet.									
Reason for Change:									
To more accurately reflect device characteristics.									
Ant	icipated impact o	n Fit, Form	, Fun	ction, Quality or	Relia	bi	lit	y (posi	itive / negative):
No anticipated impact. This is a specification change announcement only. There are no changes to the actual device.									
Changes to product identification resulting from this PCN:									
None.									
Pro	duct Affected:								
LMH0397RTVR LMH0397RTVT									

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com